## Notice of References Cited

Application/Control No. 09/764,750			Applicant(s)/Patent Under Reexamination LIN ET AL.		
Examiner		Art Unit			
Jennifer T Nguyen		2674	Page 1 of 1		

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,606,088	08-2003	Yang et al.	345/211
	В	US-6,373,476	04-2002	Dalgleish et al.	345/204
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	Κ	US-			
	٦	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	P					
	α					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

	MONT ATENT DOCUMENTS				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	KAI ET AL., Pub. No.: US 2002/0122041 A1			
	V				
	w				
	×				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.